

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/588,966	TANAKA, MITSUNORI	
		Examiner	Art Unit	Page 1 of 1
		Michael Mapa	4113	

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	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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